

इंटरनेट

मानक

### Disclosure to Promote the Right To Information

Whereas the Parliament of India has set out to provide a practical regime of right to information for citizens to secure access to information under the control of public authorities, in order to promote transparency and accountability in the working of every public authority, and whereas the attached publication of the Bureau of Indian Standards is of particular interest to the public, particularly disadvantaged communities and those engaged in the pursuit of education and knowledge, the attached public safety standard is made available to promote the timely dissemination of this information in an accurate manner to the public.

“जानने का अधिकार, जीने का अधिकार”

Mazdoor Kisan Shakti Sangathan

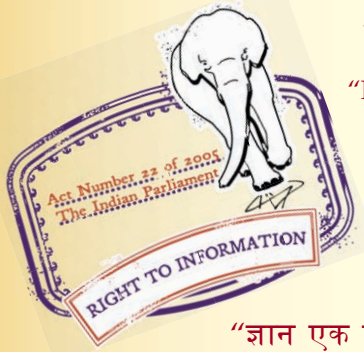
“The Right to Information, The Right to Live”

“पुराने को छोड़ नये के तरफ”

Jawaharlal Nehru

“Step Out From the Old to the New”

IS 1401 (2008): Protection of persons and equipment by enclosures - Probes for verification [ETD 32: Electrical Appliances]



“ज्ञान से एक नये भारत का निर्माण”

Satyanarayan Gangaram Pitroda

“Invent a New India Using Knowledge”



“ज्ञान एक ऐसा खजाना है जो कभी चुराया नहीं जा सकता है”

Bhartrhari—Nitiśatakam

“Knowledge is such a treasure which cannot be stolen”



BLANK PAGE



भारतीय मानक  
खोलों द्वारा व्यक्तियों और उपकरणों का  
रक्षण — सत्यापन हेतु प्रोब  
( दूसरा पुनरीक्षण )

*Indian Standard*  
PROTECTION OF PERSONS AND EQUIPMENT BY  
ENCLOSURES — PROBES FOR VERIFICATION  
( *Second Revision* )

ICS 13.260; 29.020

© BIS 2008

**BUREAU OF INDIAN STANDARDS**  
MANAK BHAVAN, 9 BAHADUR SHAH ZAFAR MARG  
NEW DELHI 110002

## NATIONAL FOREWORD

This Indian Standard (Second Revision) which is identical with IEC 61032 : 1997 'Protection of persons and equipment by enclosures — Probes for verification' issued by the International Electrotechnical Commission (IEC) was adopted by the Bureau of Indian Standards on the recommendation of the Electrical Appliances Sectional Committee and approval of the Electrotechnical Division Council.

This standard was first issued in 1959 and was revised in 1970. The second revision of this standard has been undertaken to harmonize it with the IEC 61032 : 1997.

The text of IEC Standard has been approved as suitable for publication as an Indian Standard without deviations. Certain conventions are, however, not identical to those used in Indian Standards. Attention is particularly drawn to the following:

- a) Wherever the words 'International Standard' appear referring to this standard, they should be read as 'Indian Standard'.
- b) Comma (,) has been used as a decimal marker, while in Indian Standards, the current practice is to use a point (.) as the decimal marker.

In this adopted standard, references appear to certain International Standards for which Indian Standards also exist. The corresponding Indian Standards, which are to be substituted in their respective places are listed below along with their degree of equivalence for the editions indicated:

<i>International Standard</i>	<i>Corresponding Indian Standard</i>	<i>Degree of Equivalence</i>
IEC 60529 : 1989 Degrees of protection provided by enclosures (IP Code)	IS 12360 : 1988 Voltage bands for electrical installations including preferred voltages and frequency	Technically Equivalent
IEC 60536 : 1976 Classification of electrical and electronic equipment with regard to protection against electric shock	IS 9409 : 1980 Classification of electrical and electronic equipment with regard to protection against electric shock	do

The technical committee has reviewed the provisions of the following International Standards referred in this adopted standard and has decided that they are acceptable for use in conjunction with this standard:

<i>International Standard</i>	<i>Title</i>
IEC 60050 (826) : 1982	International Electrotechnical Vocabulary (IEV) — Chapter 826: Electrical installations of buildings
ISO 4287-1 : 1984	Surface roughness — Terminology — Part 1: Surface and its parameters

Technical Corrigendum to the above International Standard has been given at the end of this publication.

Only the English language text of the International Standard has been retained while adopting it in this Indian Standard, and as such the page numbers given here are not the same as in the International Standard.

For the purpose of deciding whether a particular requirement of this standard is complied with, the final value, observed or calculated expressing the result of a test or analysis, shall be rounded off in accordance with IS 2 : 1960 'Rules for rounding off numerical values (*revised*)'. The number of significant places retained in the rounded off value should be the same as that of the specified value in this standard.

## *Indian Standard*

# PROTECTION OF PERSONS AND EQUIPMENT BY ENCLOSURES — PROBES FOR VERIFICATION

*( Second Revision )*

## **1 General**

### **1.1 Scope and object**

This International Standard specifies details and dimensions of test probes intended to verify the protection provided by enclosures with regard to:

- protection of persons against access to hazardous parts inside the enclosure;
- protection of the equipment inside the enclosure against ingress of solid foreign objects.

The object of this International Standard is:

- to bring together in one publication object probes and access probes currently specified in other standards, together with any necessary new probes;
- to guide technical committees in the selection of test probes;
- to encourage those concerned to specify test probes in accordance with those already specified in this International Standard rather than modify details and dimensions;
- to limit the further proliferation of types of test probe.

### **1.2 General recommendations**

When selecting probes, priority should be given to IP code probes.

The use of other probes, particularly probes which are not specified in this International Standard, should be limited to cases where the use of an IP code probe is for some reason impractical.

NOTE 1 – The selection of a test probe for a particular purpose is the responsibility of the relevant technical committees.

NOTE 2 – Technical committees wishing to develop new probes or to modify existing probes should submit proposals to technical committee 70 for amendment of this standard.

Application of the probes, test conditions, acceptance conditions and the procedure in case of conflicting test results are the responsibility of the relevant product committee.

Certificates based on test probes conforming to the first edition of IEC 61032 should remain valid.

## 2 Normative references

The following normative documents contain provisions which, through reference in this text, constitute provisions of this International Standard. At the time of publication, the editions indicated were valid. All normative documents are subject to revision, and parties to agreements based on this International Standard are encouraged to investigate the possibility of applying the most recent editions of the normative documents indicated below. Members of IEC and ISO maintain registers of currently valid International Standards.

IEC 60050(826): 1982, *International Electrotechnical Vocabulary (IEV) – Chapter 826: Electrical installations of buildings*

IEC 60529: 1989, *Degrees of protection provided by enclosures (IP Code)*

IEC 60536: 1976, *Classification of electrical and electronic equipment with regard to protection against electric shock*

ISO 4287-1: 1984, *Surface roughness – Terminology – Part 1: Surface and its parameters*

## 3 Definitions

For the purpose of this International Standard the following definitions apply:

### 3.1 Enclosure

A part providing protection of equipment against certain external influences and, in any direction, protection against direct contact [IEV 826-03-12]

NOTE – This definition taken from the International Electrotechnical Vocabulary (IEV) needs the following additional explanations:

- a) Enclosures provide protection of persons or livestock against access to hazardous parts.
- b) Barriers, shapes of openings or any other means – whether attached to the enclosure or formed by the enclosed equipment – suitable to prevent or limit the penetration of the specified test probes are considered as a part of the enclosure, except when they can be removed without the use of a key or tool.

(see 3.1 of IEC 60529).

### 3.2 Hazardous part

A part that is hazardous to approach or touch (see 3.5 of IEC 60529).

#### 3.2.1 Hazardous live part

A live-part which, under certain conditions of external influences, can give an electric shock (see 3.5.1 of IEC 60529).

#### 3.2.2 Hazardous mechanical part

A moving part, other than a smooth rotating shaft, that is hazardous to touch (see 3.5.2 of IEC 60529).

#### 3.2.3 Hazardous hot or glowing part

A hot or glowing part that is hazardous to touch.

### **3.3 Access probe**

A test probe simulating in a conventional manner a part of a person or a tool, or the like, held by a person to verify adequate clearance from hazardous parts (see 3.8 of IEC 60529).

### **3.4 Object probe**

A test probe simulating a solid foreign object to verify the possibility of ingress into an enclosure (see 3.9 of IEC 60529).

### **3.5 IP code probe**

A test probe to verify the degrees of protection specified in IEC 60529.

### **3.6 Other probe**

A test probe, different from IP code probes.

### **3.7 Adequate clearance for protection against access to hazardous parts**

*A distance to prevent contact or approach of an access probe to a hazardous part (see 3.7 of IEC 60529).*

NOTE – The requirements to verify adequate clearance are specified in IEC 60529.

## **4 Classification of test probes**

Test probes are classified as follows:

- a) according to their designation
  - IP code probes;
  - other probes;
- b) according to the kind of protection they are intended to check
  - access probes;
  - object probes;
- c) according to the specific hazard they are intended to check
  - probes mainly intended to be used to verify the protection of persons against access to hazardous live parts or hazardous mechanical parts;
  - probes specifically intended to be used to verify the protection of persons against access to hazardous mechanical parts;
  - probes mainly intended to be used to verify the protection of persons against access to internal parts involving thermal hazard, for instance internal hot or glowing parts;
  - probes intended to be used to verify the protection of equipment against ingress of solid foreign objects.



## 5 List of test probes

The comparative list of test probes with their application is given in table 1. Other IEC publications should refer to a test probe of this standard by means of its code (column 2) and short description (column 4), without reproduction of the relevant figure (column 3).

**Table 1 – List of test probes**

1	2	3	4	5
Probe and application <sup>3)</sup>	Probe code <sup>1)</sup>	Figure No.	Short description mm	Forces to be applied N
<b>Access probes of IEC 60529 (IP code)</b> to verify protection of persons against access to hazardous live parts or hazardous mechanical parts	A B C <sup>2)</sup> D <sup>2)</sup>	1 2 3 4	– Sphere: Ø 50 with handle – Jointed test finger – Rod: Ø 2,5 – length 100 – Wire: Ø 1,0 – length 100	50 10 3 1
<b>Object probes of IEC 60529 (IP code)</b> to verify protection of equipment against ingress of solid foreign objects	1 2	5 6	– Sphere: Ø 50 – Sphere: Ø 12,5	50 30
<b>Other access probes</b> to verify protection of persons against access to hazardous live parts or hazardous mechanical parts	11 12 13 14 15 16 17 18 19	7 8 9 10 – – 11 12 13	– Unjointed test finger – Cylindrical pin: Ø 4 – length 50 – Conical pin: Ø 3 to 4 – length 15 – Bar: 3 × 1 – Deleted – Deleted – Wire: Ø 0,5 – Small finger probe: Ø 8,6 – length 57,9 – Small finger probe: Ø 5,6 – length 44	50 * * 20 – – * 10 10
<b>Other access probes</b> to verify protection of persons against access to hazardous mechanical parts	31 32 33	14 15 –	– Cone: Ø 110/60 – Rod: Ø 25 – Deleted	50 30 –
<b>Other access probes</b> to verify protection of persons against access to hot or glowing parts	41 42 43	16 – 17	– Probe: Ø 30 – Deleted – Bar: 50 × 5	* – *

\* Without appreciable force.

1) Letter codes and the single digit codes are related to the IP code.

The first numeral of the two digit codes is related to the intended use of the probe as indicated at the beginning of the respective row.

The second numeral denotes a serial number within the group.

2) Test probes C and D are also used to verify the protection of equipment against ingress of solid foreign objects having a diameter of 2,5 mm or greater and 1 mm or greater respectively.

3) The table lists probes and their main application only; there may be other applications as defined by the relevant product standard.

## 6 Test probes

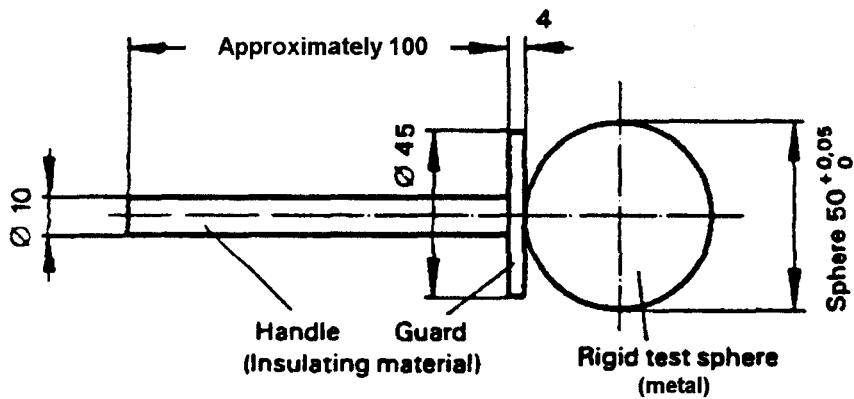
### 6.1 IP code probes

#### 6.1.1 IP code probes are intended to verify

- the protection of persons against access to hazardous parts;
- the protection of the equipment against the ingress of solid foreign objects.

#### 6.1.2 Access probes

a)



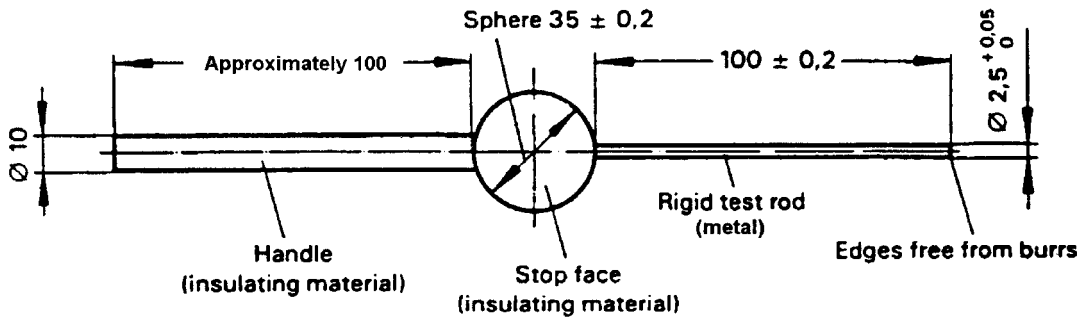
*Dimensions in millimetres*

This probe is intended to verify the protection of persons against access to hazardous parts. It is also used to verify the protection against access with the back of the hand.

**Figure 1 – Test probe A**



c)

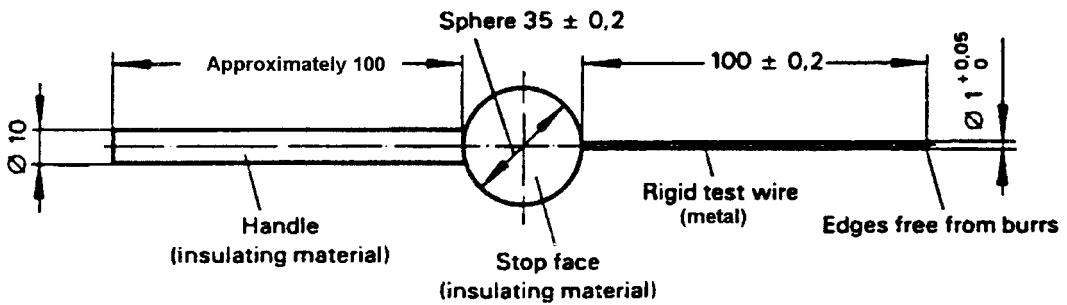


*Dimensions in millimetres*

This rod is intended to verify the protection of persons against access to hazardous parts. It is also used to verify protection against access with a tool.

Figure 3 – Test probe C

d)



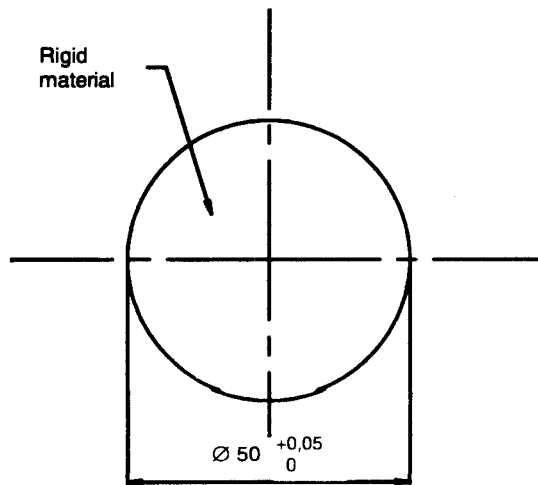
*Dimensions in millimetres*

This wire is intended to verify the protection of persons against access to hazardous parts. It is also used to verify the protection against access with a wire.

Figure 4 – Test probe D

6.1.3 Object probes

a)

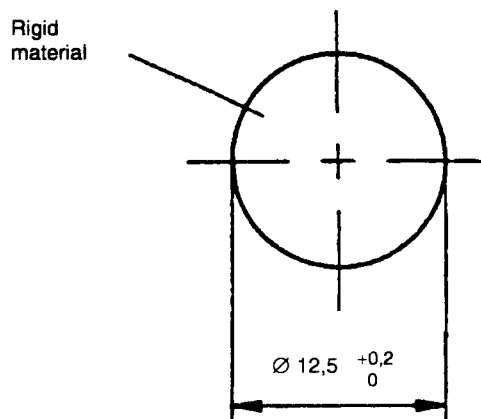


*Dimensions in millimetres*

This sphere is intended to verify the degree of protection of enclosures against ingress of solid foreign objects having a diameter of 50 mm or greater.

**Figure 5 – Test probe 1**

b)



*Dimensions in millimetres*

This sphere is intended to verify the degree of protection of enclosures against ingress of solid foreign objects having a diameter of 12,5 mm or greater.

**Figure 6 – Test probe 2**

## 6.2 Other access probes

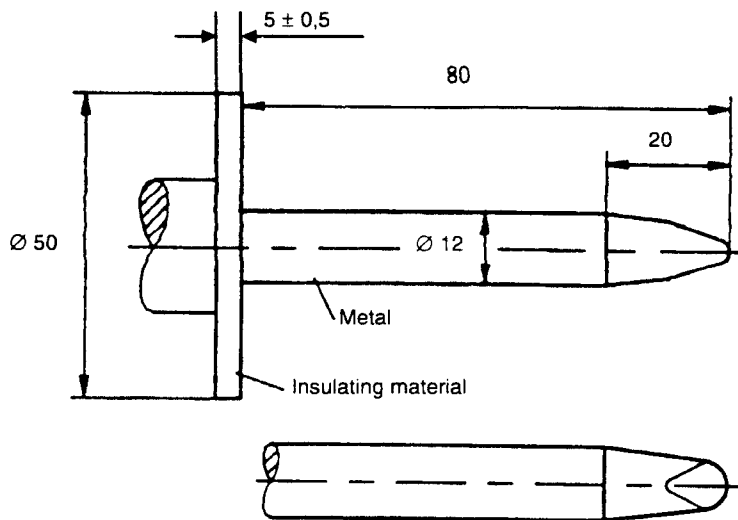
6.2.1 The probes quoted in 6.2.2 and 6.2.3 are used to cover particular requirements specified in the relevant product standards.

They should be chosen only where the use of IP code test probes is impractical.

### 6.2.2 Access probes to hazardous live parts or hazardous mechanical parts

Probes intended to verify the protection of persons against access to hazardous live parts or hazardous mechanical parts:

a)



*Dimensions in millimetres*

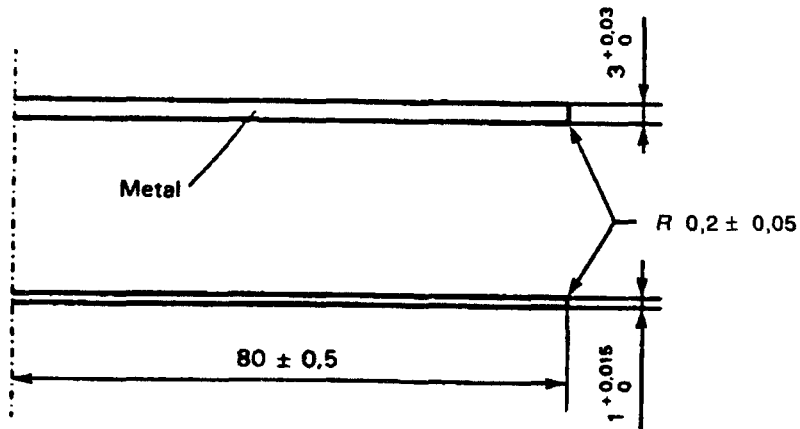
For dimensions of the fingertip and tolerances: see figure 2.

This probe may be used to verify the protection of persons against access to hazardous parts, and to verify the mechanical strength of openings in the enclosure or internal barriers.

**Figure 7 – Test probe 11**



d)

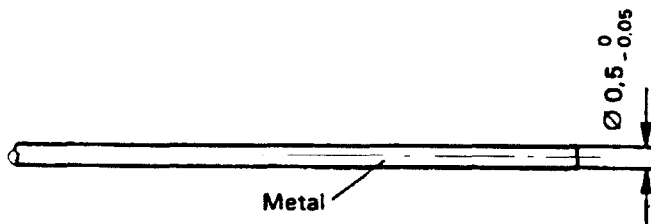


*Dimensions in millimetres*

This bar is intended to verify the protection against access to hazardous live parts of socket-outlets through shutters.

**Figure 10 – Test probe 14**

e)



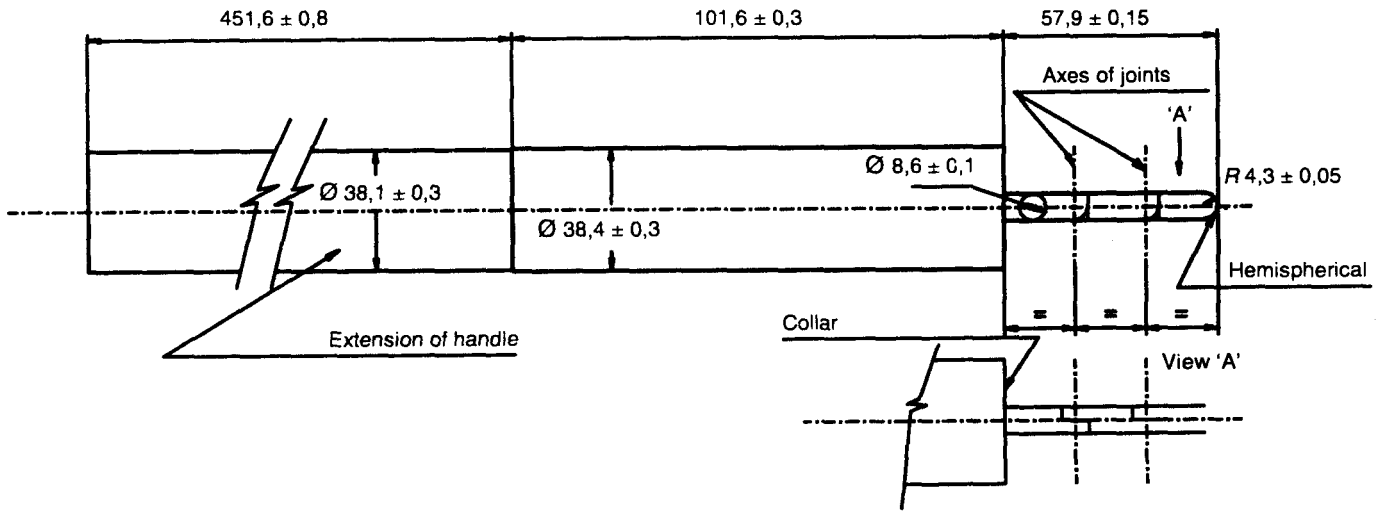
*Dimensions in millimetres*

This wire is intended to verify protection against access to hazardous live parts of electrical toys.

**Figure 11 – Test probe 17**



f)



*Dimensions in millimetres*

- Finger: metal material
- Handle: insulating material

The extension of the handle represents the arm of the child.

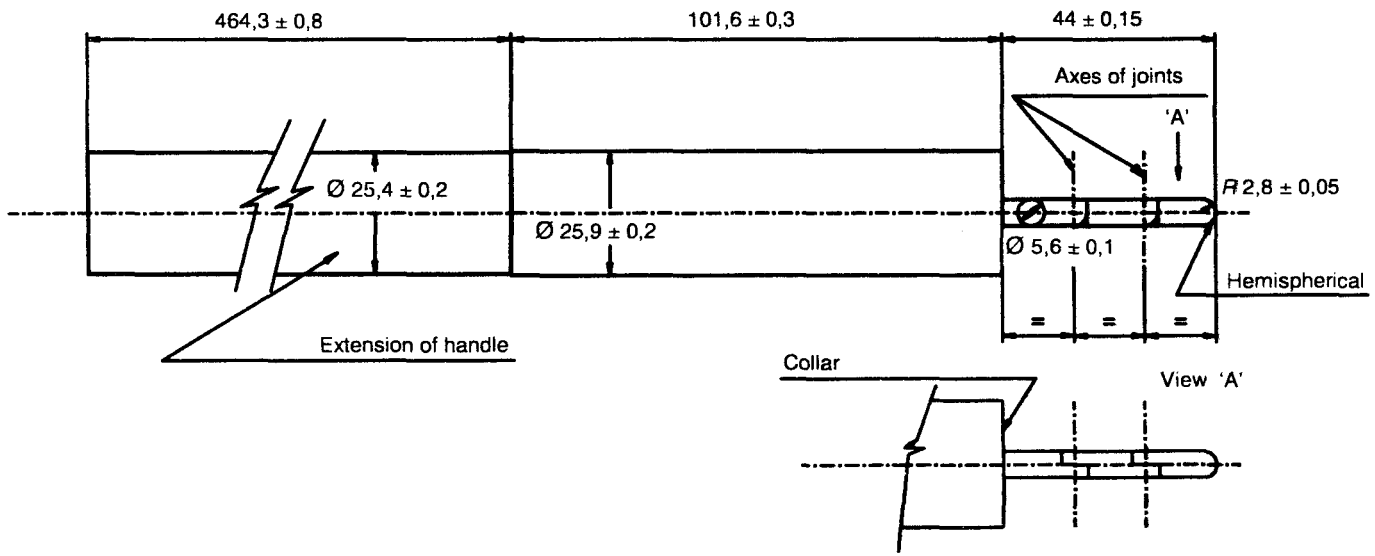
The handle is provided with an extension 451,6 mm long, and the probe should be applied with or without this extension, whichever is the more onerous condition.

Both joints shall permit movement in the same plane and the same direction through an angle of 90°.

This probe is intended to simulate access to hazardous parts by children of more than 36 months and less than 14 years.

**Figure 12 – Test probe 18 (small finger probe  $\varnothing 8,6$ )**

g)



Dimensions in millimetres

- Finger: metal material
- Handle: insulating material

The extension of the handle represents the arm of the child.

The handle is provided with an extension, 464,3 mm long and the probe should be applied with or without this extension, whichever is the more onerous condition.

Both joints shall permit movement in the same plane and the same direction through an angle of 90°.

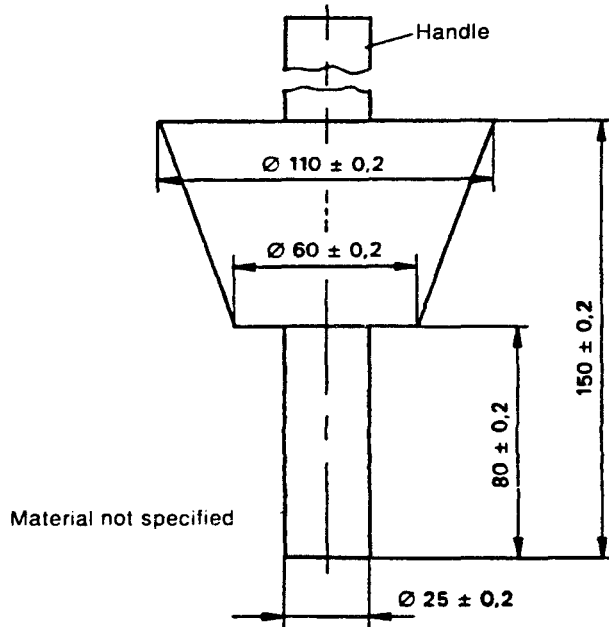
This probe is intended to simulate access to hazardous parts by children of 36 months or less.

**Figure 13 – Test probe 19 (small finger probe Ø 5,6)**

6.2.3 Access probes to hazardous mechanical parts

Probes specifically intended to verify the protection of persons against access to hazardous mechanical parts.

a)

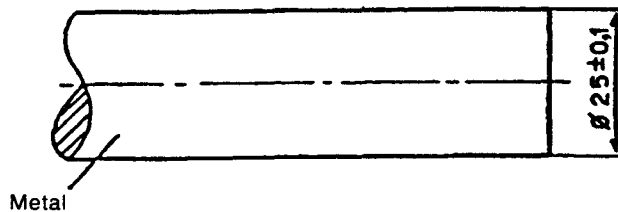


*Dimensions in millimetres*

This probe is intended to verify the protection against access to hazardous mechanical parts of the grinding system of food waste disposal units.

Figure 14 – Test probe 31

b)



*Dimensions in millimetres*

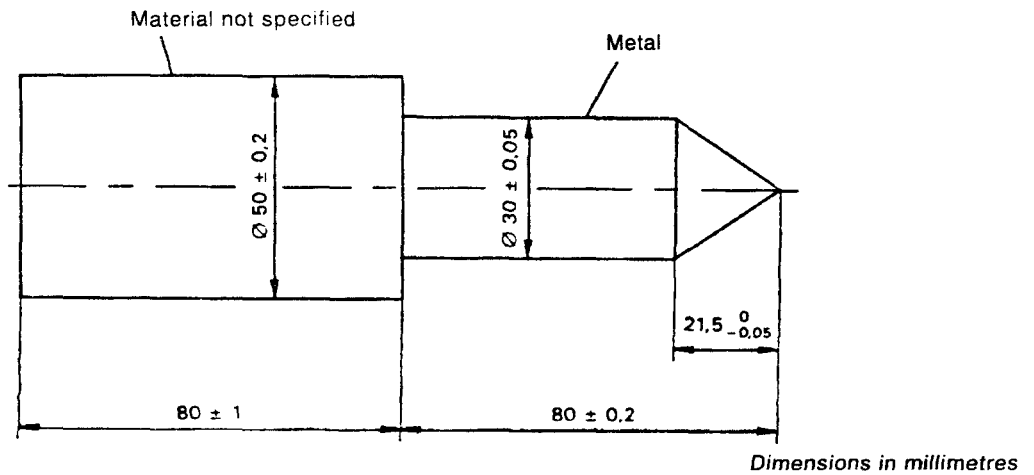
This rod is intended to verify the protection provided by fan guards against access to hazardous mechanical parts.

Figure 15 – Test probe 32

6.2.4 Access probes to hazardous hot or glowing parts

Probes intended to verify the protection of persons against access to hazardous hot or glowing parts.

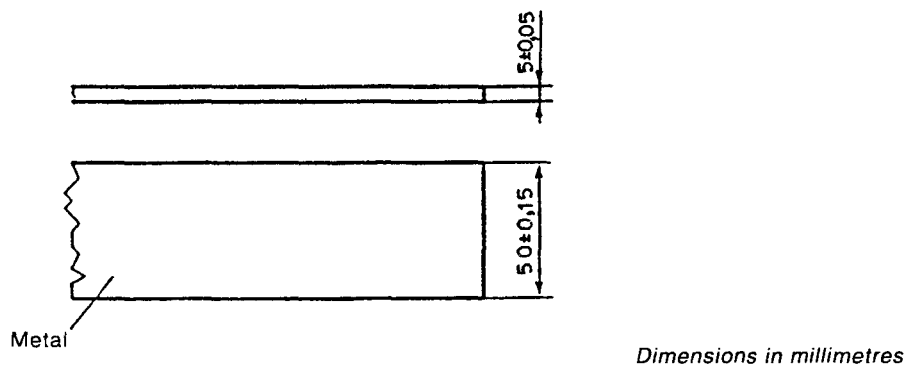
a)



This probe is intended to verify the protection against access to glowing heating elements.

Figure 16 – Test probe 41

b)



This bar is intended to verify the protection of fixed and portable visibly glowing radiant heaters.

Figure 17 – Test probe 43

## **7 Design characteristics of test probes**

**7.1** Adequate means (e.g. spring) shall be specified for measuring the force to be applied.

**7.2** The surface roughness Ra according to ISO 4287-1 of metal parts of test probes, when delivered, shall not exceed 1,6 µm.

All parts of the probes that can be in contact with the test specimen shall be of a minimum hardness of 50 HCR (Rockwell, C scale).

NOTE 1 – When it is necessary to check by electrical means, a terminal should be provided to permit connection of an extra low voltage supply.

Unless otherwise specified in the product standards, it is recommended that the voltage of the indicator circuit is not less than 40 V and not more than 50 V.

NOTE 2 – Test probes should be protected from corrosion. If a probe is made of material susceptible to corrosion some protection should be afforded, especially when not in use. Use of oil and similar protection is recommended.

NOTE 3 – Handles should be designed so that they can be securely held.

## Annex A (informative)

### Effect of tolerances of test probes on equipment and test results

#### A.1 General

Test probes are well established and specified means to verify the protection of electrical equipment with regard to access to hazardous parts.

Tight tolerances are desired to ensure compatibility and reproducibility of test results, however, wide tolerances are required for economic manufacture of the probes and to allow for wear due to frequent use.

It is important that both the designers of electrical equipment with hazardous parts and the users of test probes are aware of these facts and of the natural limits in the application of test probes.

As a matter of principle, the relevant dimensions of electrical apparatus (e.g. apertures or clearances) should be designed to provide an ample safety margin between the hazardous parts and the test probe taking account of the greatest tolerance applicable for the probe.

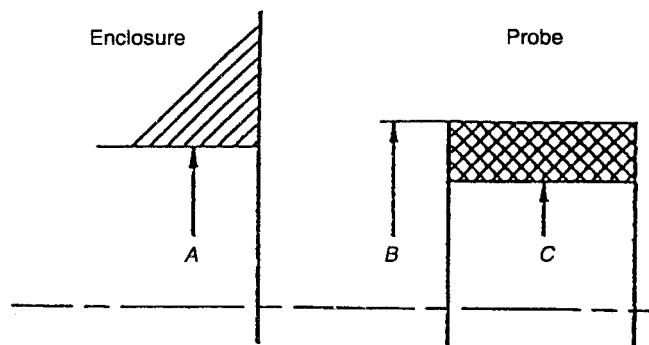
The following examples are given to explain the matter in more detail.

#### A.2 Test probes of undefined length

Examples: probes 17, 32, 43.

According to the test conditions specified in the relevant product standards, the purpose of the test is to verify the protection of persons against access to hazardous parts inside an enclosure.

These probes are designed to show that no access can be made into the enclosure (see figure A.1).



**Figure A.1 – Tolerance range on the diameter of a cylindrical test probe**

*A*: maximum aperture in the enclosure under test

*B*: maximum dimension of the probe

*C*: minimum dimension of the probe

*B-C*: tolerance range of the probe

Instruction for the designer of the equipment:  $A < C$

Instruction for the user of the test probe:

$A > B$ : test failed

$A < C$ : test passed

$C < A < B$ : range of uncertainty which can be avoided if the rule  $A < C$  is followed

### A.3 Test probes of defined length

Examples: probes C, D, 14, and the cylindrical parts of probes B, 11, 31, 41.

These probes simulate parts of the human body or tools held by a person.

According to the test conditions specified in the relevant product standards, the purpose of the test is to verify the protection of persons against access to hazardous parts inside an enclosure.

The probe may penetrate through an opening until its stop face, but adequate clearance is kept between the probe and hazardous parts (see figure A.2).

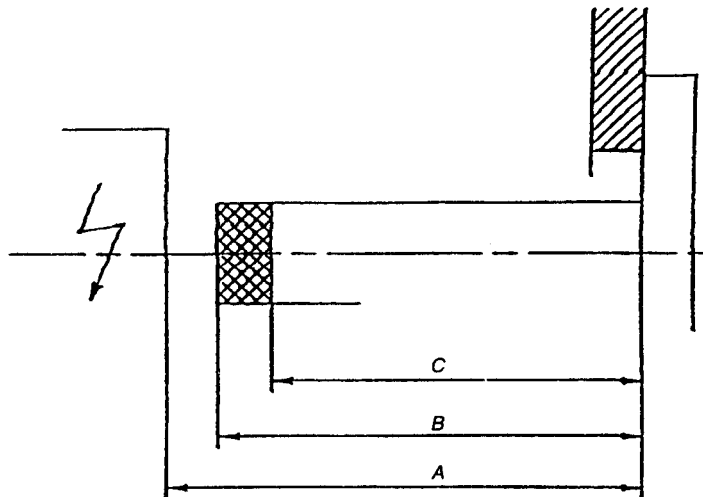


Figure A.2 – Tolerance range on the length of a test probe

- A: shortest distance of hazardous parts under test
- B: maximum dimension of the probe
- C: minimum dimension of the probe
- B-C: tolerance range of the probe

Instruction for the designer:

$A > B$  including the specified clearance dimension in case of high-voltage equipment

Instructions for the user of the test probe:

$A \leq C$ : test failed

$A > B$ : test passed

$C < A \leq B$ : range of uncertainty which can be avoided if the rule  $A > B$  is followed

#### **A.4 Test probes with tapered section**

Examples: probes B, 11, 13, 31, 41.

Basically the rules given in A.3 apply.

The penetration depth of the tapered section is limited by the diameter of the probe, however, particularly in case of small taper angles there is a wide range of uncertainty, as shown in figure A.3.

The general statements made in the initial part of this annex should be carefully noted by designers if test probes with tapered sections need to be applied.



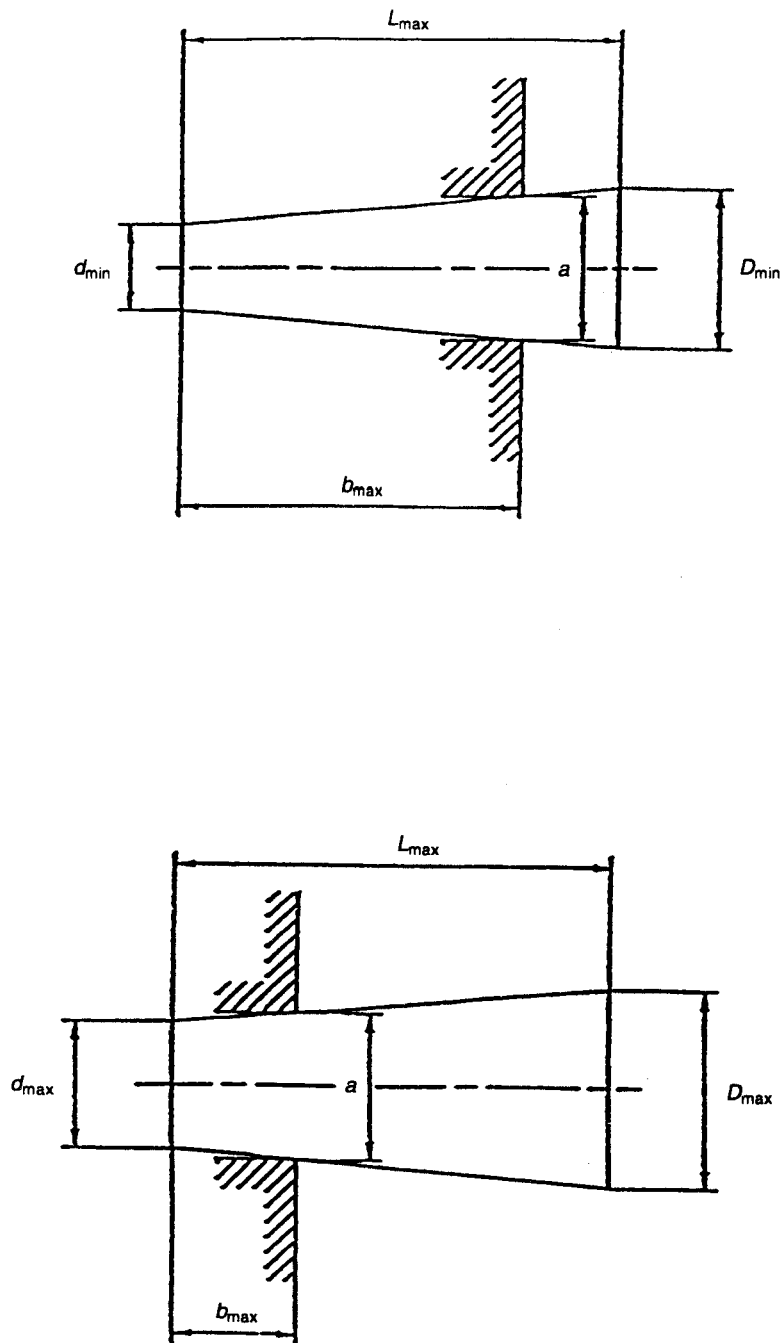


Figure A.3 – Variation of penetration depth  $b$  with tapered test probes

The following graphs show the penetration depths  $b$  and their deviations as a function of the opening widths  $a$  and the tolerance on dimensions  $b$  for test probes with tapered sections listed in this standard:

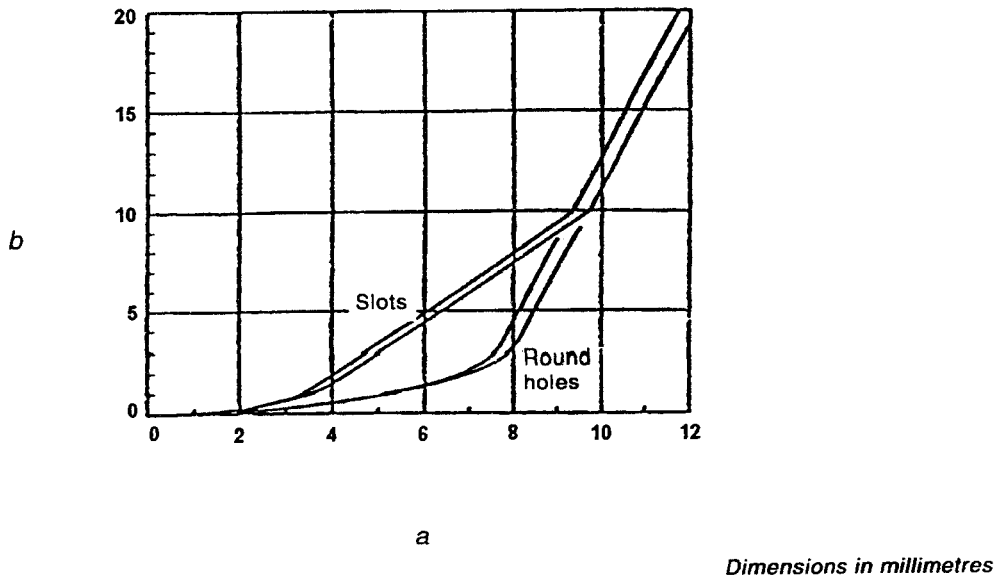


Figure A.4 – Tolerance range of the penetration depths  $b$  through opening width  $a$  for test probe B: jointed test finger and test probe 11: unjointed test finger

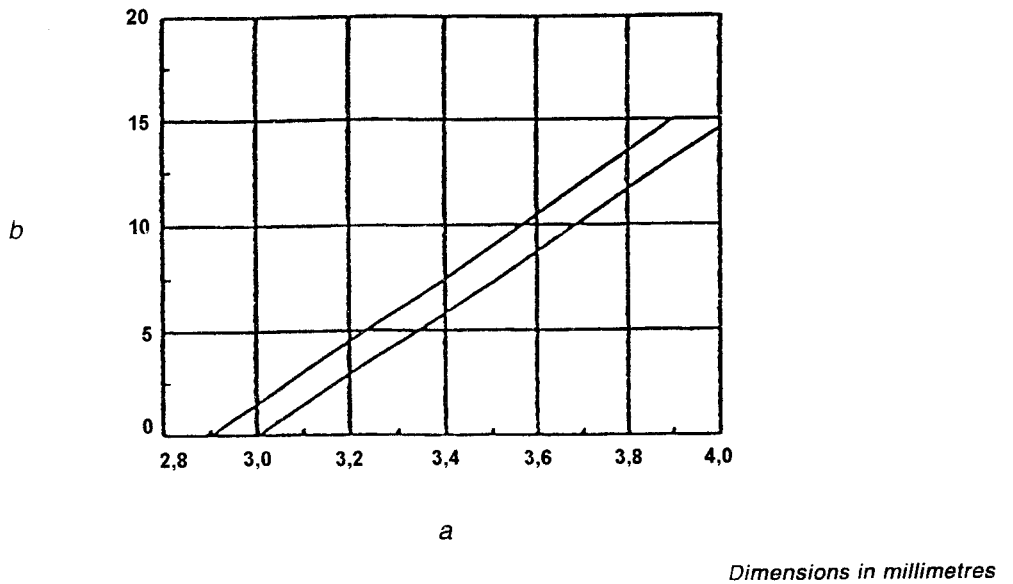
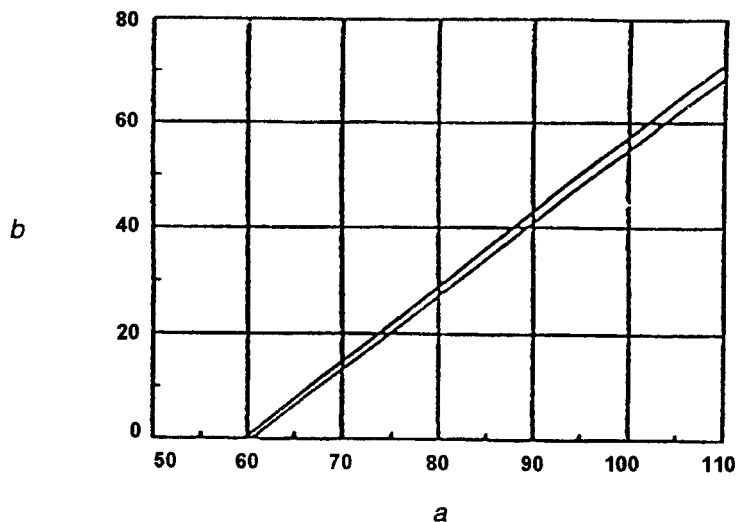
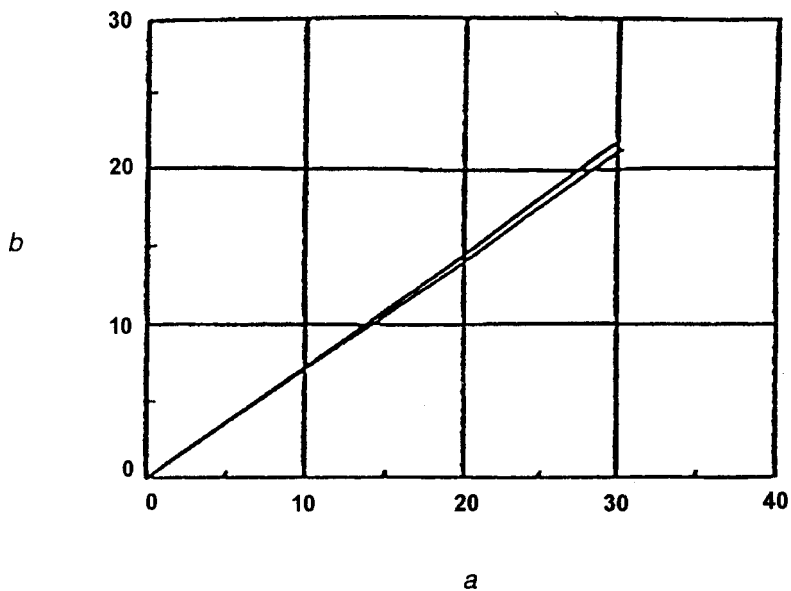


Figure A.5 – Tolerance range of the penetration depths  $b$  through opening width  $a$  for test probe 13: conical pin,  $\varnothing$  3 to 4, 15 long



*Dimensions in millimetres*

**Figure A.6 – Tolerance range of the penetration depths  $b$  through opening width  $a$  for test probe 31: cone  $\varnothing$  110/60**



*Dimensions in millimetres*

**Figure A.7 – Tolerance range of the penetration depths  $b$  through opening width  $a$  for test probe 41: probe  $\varnothing$  30**

## Annex B (informative)

### Rules for tolerancing future probes

#### B.1 Dimensions

**B.1.1** Dimensions of active parts of probes should be toleranced according to tables 1, 2 and 3 of ISO 2768-1\*, as follows.

- Linear dimensions should be toleranced according table 1 and namely
  - tolerance class fine for metallic parts, and
  - tolerance class medium for insulating or not-specified parts.
- Broken edges (*external radii and chamfer heights*) should have tolerance class fine/medium, as specified in table 2.
- Angular dimensions should have tolerance class *fine/medium*, as specified in table 3.

**B.1.2** Dimensions of non-active parts, such as handles, guards, etc., are given without tolerances.

#### B.2 Forces

The forces to be applied to the probes should have a tolerance of  $\pm 10\%$ .

---

\* ISO 2768-1: 1989, *General tolerances – Part 1: Tolerances for linear and angular dimensions without individual tolerance indications*

## CORRIGENDUM 1

Page 17

Figure 2 – Test probe B

*Under the figure, replace the existing tolerance on dimensions on angles by the following:*

– on angles:  $\begin{matrix} 0 \\ -10 \end{matrix}$

## Bureau of Indian Standards

BIS is a statutory institution established under the *Bureau of Indian Standards Act*, 1986 to promote harmonious development of the activities of standardization, marking and quality certification of goods and attending to connected matters in the country.

### Copyright

BIS has the copyright of all its publications. No part of these publications may be reproduced in any form without the prior permission in writing of BIS. This does not preclude the free use, in course of implementing the standard, of necessary details, such as symbols and sizes, type or grade designations. Enquiries relating to copyright be addressed to the Director (Publications), BIS.

### Review of Indian Standards

Amendments are issued to standards as the need arises on the basis of comments. Standards are also reviewed periodically; a standard along with amendments is reaffirmed when such review indicates that no changes are needed; if the review indicates that changes are needed, it is taken up for revision. Users of Indian Standards should ascertain that they are in possession of the latest amendments or edition by referring to the latest issue of 'BIS Catalogue' and 'Standards: Monthly Additions'.

This Indian Standard has been developed from Doc: No. ETD 32 (5801).

### Amendments Issued Since Publication

Amendment No.	Date of Issue	Text Affected

## BUREAU OF INDIAN STANDARDS

### Headquarters:

Manak Bhavan, 9 Bahadur Shah Zafar Marg, New Delhi 110 002

Telephones: 2323 0131, 2323 3375, 2323 9402

Website: [www.bis.org.in](http://www.bis.org.in)

### Regional Offices:

	Telephones
Central : Manak Bhavan, 9 Bahadur Shah Zafar Marg NEW DELHI 110 002	{ 2323 7617 2323 3841
Eastern : 1/14, C.I.T. Scheme VII M, V.I.P. Road, Kankurgachi KOLKATA 700 054	{ 2337 8499, 2337 8561 2337 8626, 2337 9120
Northern : SCO 335-336, Sector 34-A, CHANDIGARH 160 022	{ 260 3843 260 9285
Southern : C.I.T. Campus, IV Cross Road, CHENNAI 600 113	{ 2254 1216, 2254 1442 2254 2519, 2254 2315
Western : Manakalaya, E9 MIDC, Marol, Andheri (East) MUMBAI 400 093	{ 2832 9295, 2832 7858 2832 7891, 2832 7892

**Branches:** AHMEDABAD. BANGALORE. BHOPAL. BHUBANESHWAR. COIMBATORE. FARIDABAD. GHAZIABAD. GUWAHATI. HYDERABAD. JAIPUR. KANPUR. LUCKNOW. NAGPUR. PARWANOO. PATNA. PUNE. RAJKOT. THIRUVANANTHAPURAM. VISAKHAPATNAM.